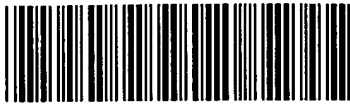


Search Notes

Application/Control No.

10/774,371

Examiner

Alain L. Bashore

Applicant(s)/Patent under
Reexamination

TAKAHASHI ET AL.

Art Unit

1762

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
previous search updated	3/6/2006	AB
EAST (attached)	3/6/2006	AB